

Gate Turn-off Thyristor

Replaces January 2000 version, DS4609-4.0

DS4609-4.1 February 2002

KEY PARAMETERS

700A

APPLICATIONS

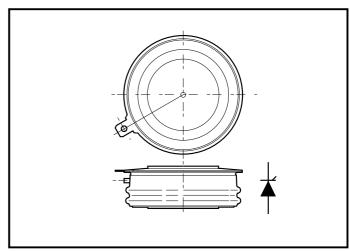
- Variable speed A.C. motor drive inverters (VSD-AC)
- Uninterruptable Power Supplies
- High Voltage Converters
- Choppers
- Welding
- Induction Heating
- DC/DC Converters

FEATURES

- Double Side Cooling
- High Reliability In Service
- High Voltage Capability
- Fault Protection Without Fuses
- High Surge Current Capability
- Turn-off Capability Allows Reduction In Equipment Size And Weight. Low Noise Emission Reduces Acoustic Cladding Necessary For Environmental Requirements

V_{DRM} 1300V I_{T(AV)} 250A dV_D/dt 500V/μs di_T/dt 500A/μs

I_{TCM}



Outline type code: E. See Package Details for further information.

VOLTAGE RATINGS

Type Number	Repetitive Peak Off-state Voltage	Repetitive Peak Reverse Voltage	Conditions
	V _{DRM} V	V _{RRM}	
DGT304SE13	1300	16	$T_{vj} = 125^{\circ}C, I_{DM} = 50mA,$ $I_{RRM} = 50mA, V_{RG} = 2V$

CURRENT RATINGS

Symbol	Parameter	Conditions	Max.	Units
I _{TCM}	Repetitive peak controllable on-state current	$V_D = 60\%V_{DRM}, T_j = 125^{\circ}C, di_{GQ}/dt = 15A/\mu s, Cs = 2.0\mu F$	700	А
I _{T(AV)}	Mean on-state current	$T_{HS} = 80^{\circ}C$. Double side cooled. Half sine 50Hz.	250	А
I _{T(RMS)}	RMS on-state current	$T_{HS} = 80^{\circ}C$. Double side cooled. Half sine 50Hz.	390	А

SURGE RATINGS

Symbol	Parameter	Conditions	Max.	Units
I _{TSM}	Surge (non-repetitive) on-state current	10ms half sine. T _j = 125°C	4.0	kA
l²t	I ² t for fusing	10ms half sine. T _j =125°C	80000	A²s
di _T /dt	Critical rate of rise of on-state current	$V_{\rm D} = 60\% \ V_{\rm DRM}, \ I_{\rm T} = 700 \mbox{A}, \ T_{\rm j} = 125 \mbox{°C}, \ I_{\rm FG} > 20 \mbox{A},$ Rise time < 1.0 μ s	500	A/μs
dV _D /dt	Rate of rise of off-state voltage	To 80% V_{DRM} ; $R_{GK} \le 1.5Ω$, $T_j = 125$ °C	500	V/μs

GATE RATINGS

Symbol	Parameter	Conditions	Min.	Max.	Units
V _{RGM}	Peak reverse gate voltage	This value maybe exceeded during turn-off	-	16	V
I _{FGM}	Peak forward gate current		-	50	А
P _{FG(AV)}	Average forward gate power		-	10	W
P _{RGM}	Peak reverse gate power		-	6	kW
di _{GQ} /dt	Rate of rise of reverse gate current		10	50	A/μs
t _{ON(min)}	Minimum permissable on time		20	-	μs
t _{OFF(min)}	Minimum permissable off time		40	-	μs

THERMAL RATINGS

Symbol	Parameter	Conditions		Min.	Max.	Units
	DC thermal resistance - junction to heatsink surface	Double side cooled		-	0.075	°C/W
$R_{th(j-hs)}$		Anode side cooled		-	0.12	°C/W
		Cathode side cooled		-	0.20	°C/W
R _{th(c-hs)}	Contact thermal resistance	Clamping force 5.5kN With mounting compound	per contact	-	0.018	°C/W
T _{vj}	Virtual junction temperature			-	125	°C
T _{OP} /T _{stg}	Operating junction/storage temperature range			-40	125	°C
-	Clamping force			5.0	6.0	kN

CHARACTERISTICS

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Symbol	Parameter	Conditions	Min.	Max.	Units
$V_{\scriptscriptstyle TM}$	On-state voltage	At 600A peak, $I_{G(ON)} = 2A d.c.$	-	2.2	V
I _{DM}	Peak off-state current	$At = V_{DRM}, V_{RG} = 2V$	-	25	mA
I _{RRM}	Peak reverse current	At V _{RRM}	-	50	mA
$V_{\rm GT}$	Gate trigger voltage	$V_{D} = 24V, I_{T} = 100A, T_{j} = 25^{\circ}C$	-	0.9	V
I _{GT}	Gate trigger current	$V_D = 24V, I_T = 100A, T_j = 25^{\circ}C$	-	1.0	Α
I _{RGM}	Reverse gate cathode current	V _{RGM} = 16V, No gate/cathode resistor	-	50	mA
E _{on}	Turn-on energy	$V_{D} = 900V$, $I_{T} = 600A$, $dI_{T}/dt = 300A/\mu s$	-	130	mJ
t _d	Delay time	$I_{FG} = 20A$, rise time < 1.0 μ s	-	1.5	μs
t _r	Rise time	$R_L = (Residual inductance 3\mu H)$	-	3.0	μs
E _{OFF}	Turn-off energy		-	350	mJ
t _{gs}	Storage time	I _T =600A, V _{DM} = 750V	-	10	μs
t _{gf}	Fall time	Snubber Cap Cs = 1.5μF,	-	11	μs
t _{gq}	Gate controlled turn-off time	$di_{GQ}/dt = 15A/\mu s$	-	0.9	μs
Q_{gQ}	Turn-off gate charge	$R_L = (Residual inductance 3\mu H)$	-	700	μС
Q_{GQT}	Total turn-off gate charge		-	1400	μC

CURVES

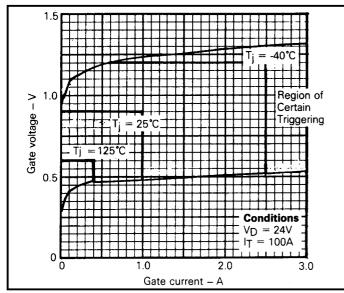


Fig.1 Gate characteristics

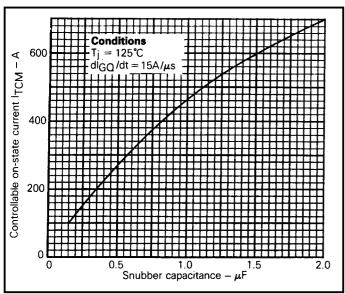


Fig.3 Dependence of $\rm I_{TCM}$ on $\rm C_S$

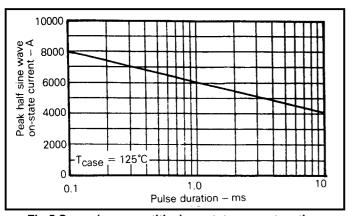


Fig.5 Surge (non-repetitive) on-state current vs time

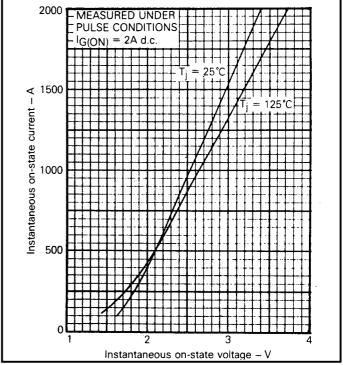


Fig.2 Maximum (limit) on-state characteristics

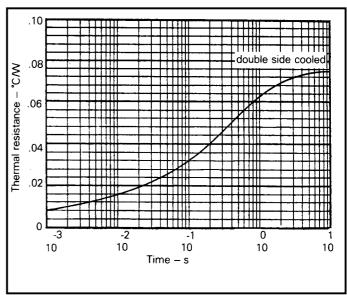


Fig.4 Maximum (limit) transient thermal resistance

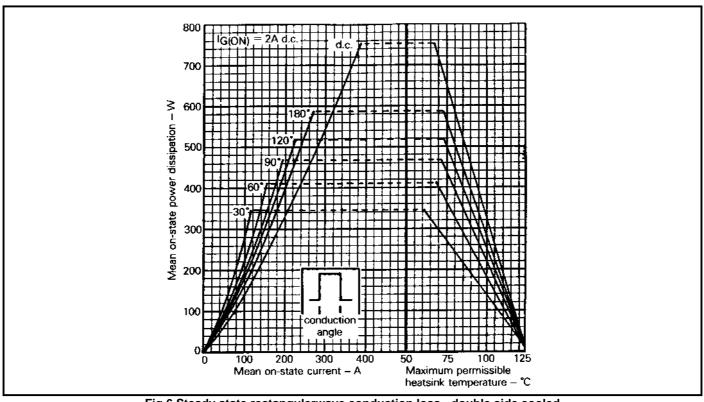


Fig.6 Steady state rectangulerwave conduction loss - double side cooled

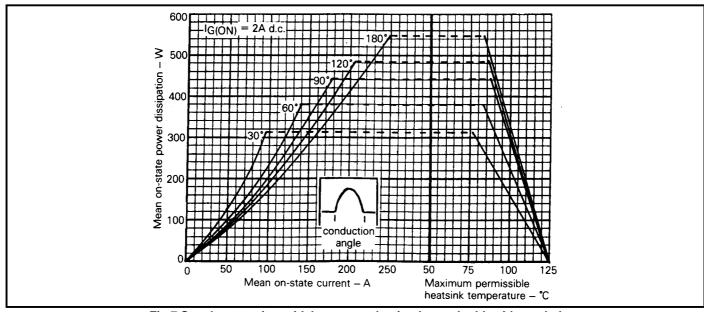


Fig.7 Steady state sinusoidal wave conduction loss - double side cooled

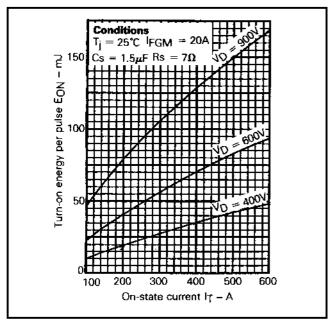


Fig.8 Turn-on energy vs on-state current

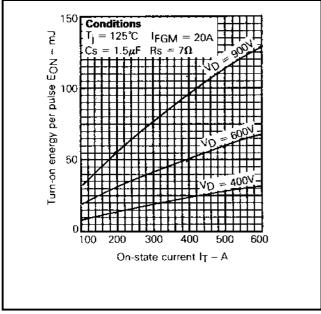


Fig.10 Turn-on energy vs on-state current

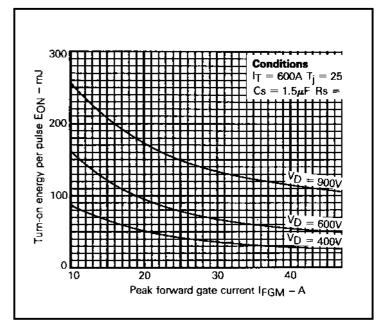


Fig.9 Turn-on energy vs peak forward gate current

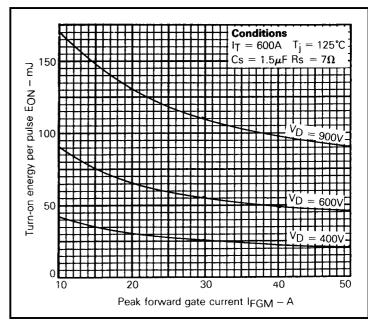


Fig.11 Turn-on energy vs peak forward gate current

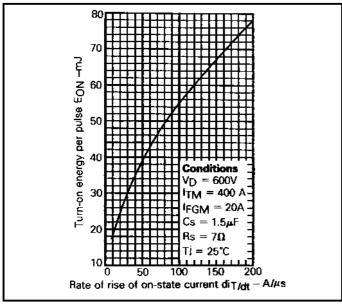


Fig.12 Turn-on energy vs rate of rise of on-state current

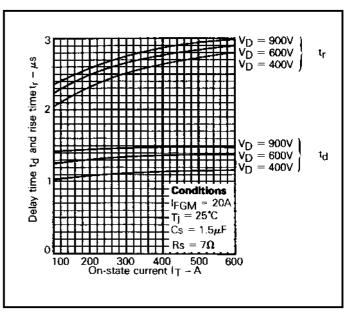


Fig.13 Delay time and rise time vs on-state current

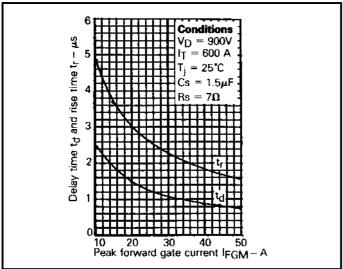


Fig.14 Delay time and rise time vs peak forward gate current

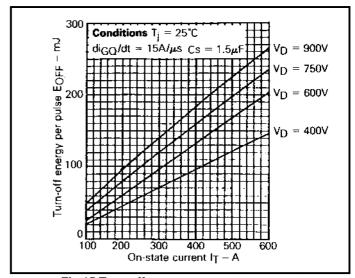
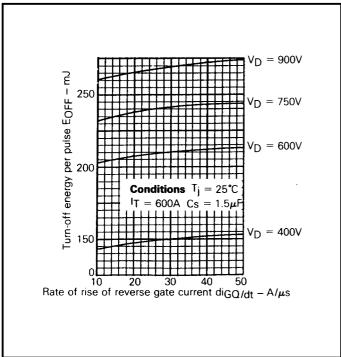
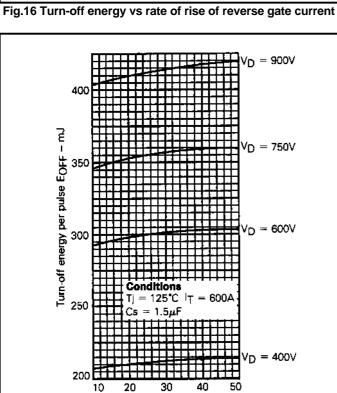


Fig.15 Turn-off energy vs on-state current





Rate of rise of reverse gate current digQ/dt - A/µs

Fig.18 Turn-off energy vs rate of rise of reverse gate current

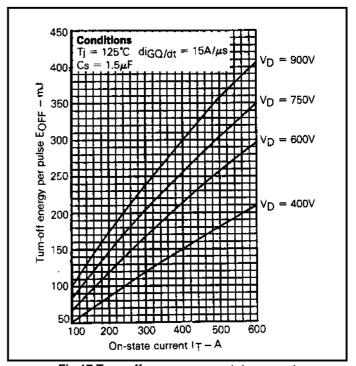


Fig.17 Turn-off energy vs on-state current

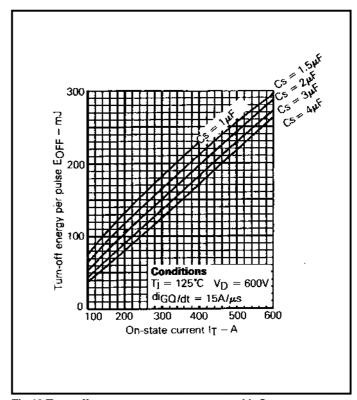


Fig.19 Turn-off energy vs on-state current with \mathbf{C}_{S} as $\,$ parameter

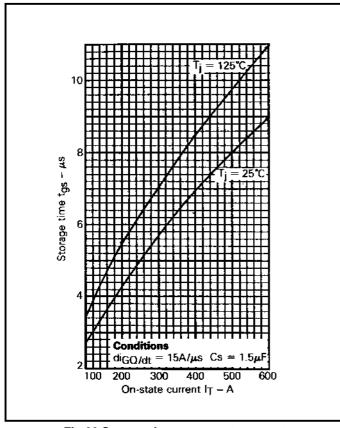


Fig.20 Storage time vs on-state current

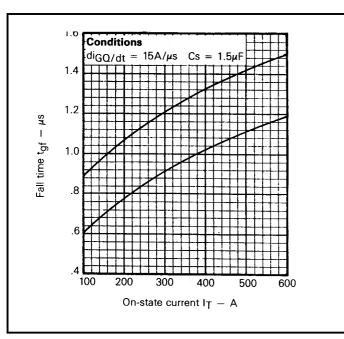


Fig.22 Fall time vs on-state current

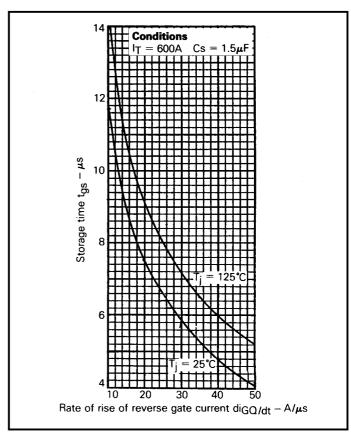


Fig.21 Storage time vs rate of rise of reverse gate current

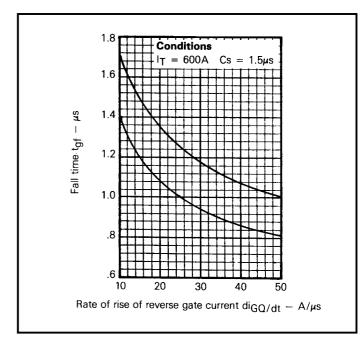


Fig.23 Fall time vs rate of rise of reverse gate current

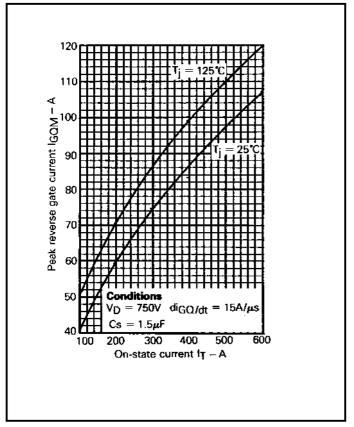


Fig.24 Peak reverse gate current vs on-state current

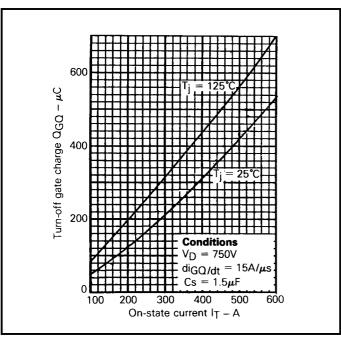


Fig.26 Turn-off gate charge vs on-state current

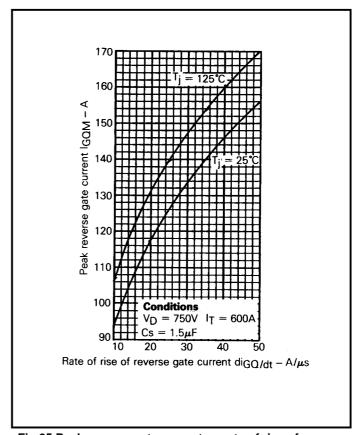


Fig.25 Peak reverse gate current vs rate of rise of reverse gate current

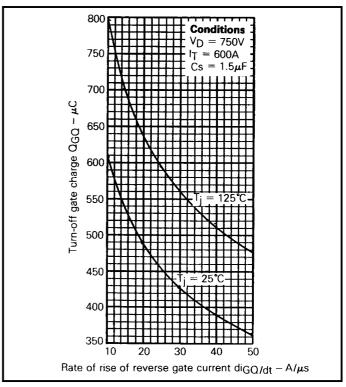


Fig.27 Turn-off gate charge vs rate of rise of reverse gate current

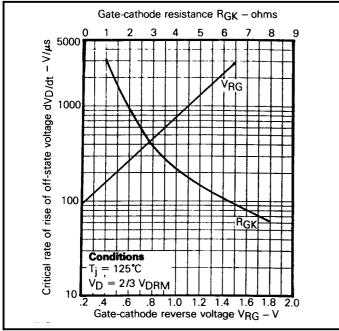


Fig.28 Dependence of critical dV_D/dt on gate-cathode resistance and gate-cathode reverse voltage

Snubber Capacitor Cs (μF)	Snubber Resistor Rs (Ω)	Minimum Reset Time (μs)
2	7	35
	5	30
1.5	7	26
1.5	5	22
4	7	17
<u>'</u>	5	15

Table of snubber discharge time variation with snubber capacitor value.

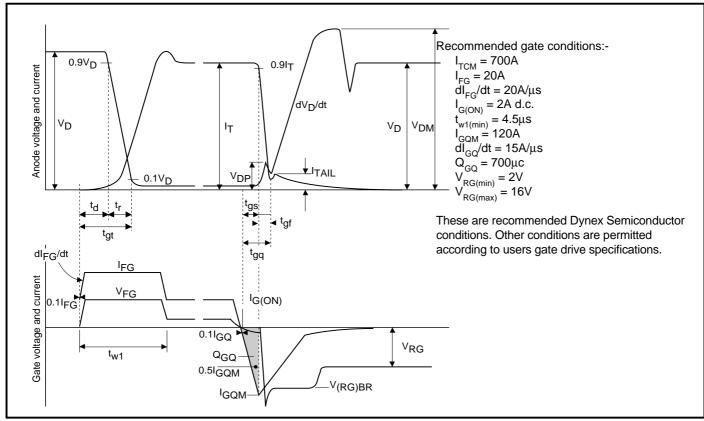
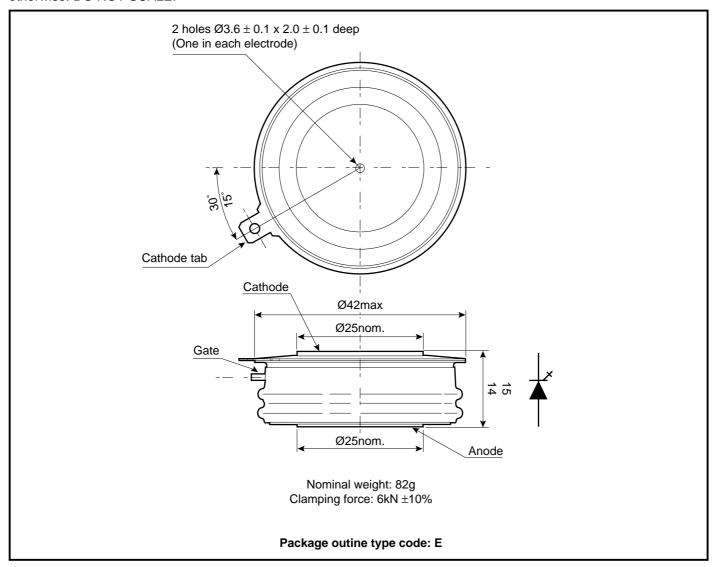


Fig.29 General switching waveforms

PACKAGE DETAILS

For further package information, please contact your local Customer Service Centre. All dimensions in mm, unless stated otherwise. DO NOT SCALE.



ASSOCIATED PUBLICATIONS

Title	Application Note	
	Number	
Calculating the junction temperature or power semiconductors	AN4506	_
GTO gate drive units	AN4571	
Recommendations for clamping power semiconductors	AN4839	
Use of V _{TO} , r _T on-state characteristic	AN5001	
Impoved gate drive for GTO series connections	AN5177	

POWER ASSEMBLY CAPABILITY

The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink / clamping systems in line with advances in device types and the voltage and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group continues to offer high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the up to date CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete solution (PACs).

DEVICE CLAMPS

Disc devices require the correct clamping force to ensure their safe operation. The PACs range offers a varied selection of preloaded clamps to suit all of our manufactured devices. This include cube clamps for single side cooling of 'T' 22mm

Clamps are available for single or double side cooling, with high insulation versions for high voltage assemblies.

Please refer to our application note on device clamping, AN4839

HEATSINKS

Power Assembly has it's own proprietary range of extruded aluminium heatsinks. They have been designed to optimise the performance or our semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest Sales Representative or the factory.



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